



## Supporting Information

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Novel Dimethylmethylene-Bridged Triphenylamine-PDI  
Acceptor for Bulk-Heterojunction Organic Solar Cells

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**Materials and Instruments:** All chemicals were purchased from commercial suppliers unless otherwise noted and used without further purification. All reactions were performed under a nitrogen atmosphere. Diethyl ether, tetrahydrofuran and toluene were distilled from sodium benzophenone. Intermediate PDI-CC was synthesized according to the reported procedures,<sup>[1]</sup> and DMTPA-3I was synthesized with slight modification to the reported method.<sup>[2]</sup>

Nuclear magnetic resonance (NMR) spectra were recorded on a Bruker Ultrashield 400 Plus NMR spectrometer. Thermogravimetric analyses (TGA) were conducted on a TA Instruments Q5000IR at a heating rate of 20 °C min<sup>-1</sup> under nitrogen gas flow. UV-vis spectra were recorded on a PerkinElmer Lambda 20 UV-vis spectrophotometer. Cyclic voltammetry (CV) measurements were carried out in a deoxygenated anhydrous acetonitrile solution on a CHI600 electrochemical workstation. Pt disk was used as the working electrode, Ag/AgNO<sub>3</sub> as the reference electrode, Pt wire as the counter electrode, and 0.1 M tetrabutylammonium hexafluorophosphate as the supporting electrolyte, and the measurements were calibrated with ferrocene (Fc) as the internal standard. AFM measurements were performed by using a Scanning Probe Microscope Dimension 3100 in tapping mode. All film samples were spin-casted onto ITO/ZnO substrates. XRD was carried out on a Bruker D8 Discovery with General Area Detector Diffraction System with a Cu K $\alpha$  radiation excited at 40 kV and 40 mA. The incoming X-ray was scanned at the grazing angle between 0.5-2.5 degree.

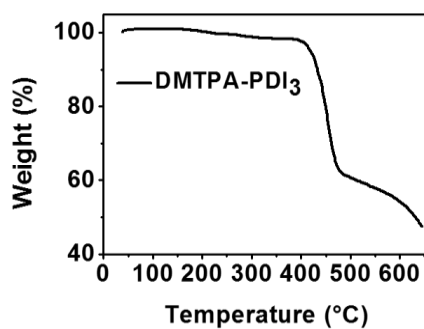
***Theoretical Calculation:*** Theoretical calculations for DMTPA-PDI<sub>3</sub> were performed by Gaussian 09 program<sup>[3]</sup> using Density Functional Theory (DFT). To simplify computations and enhance computational efficiency, the N-hexylheptyl group of DMTPA-PDI<sub>3</sub> was replaced with a simple N-methyl group, and geometric structural optimization was performed at the B3LYP/6-31G\* level, yielding optimized geometric structures to obtain the corresponding electron density.

**Hole- and Electron-only Devices:** The electron and hole mobilities were evaluated using space charge limited current (SCLC) method using electron- and hole-only devices with respective device architectures of ITO/PEDOT:PSS/PTB7-Th:DMTPA-PDI<sub>3</sub> (140 nm) /MoO<sub>3</sub>/Ag and ITO/ZnO/PTB7-Th:DMTPA-PDI<sub>3</sub> (140 nm)/ZnO/Ag. The current-voltage curves were obtained and fitted to a space charge limited form described by:

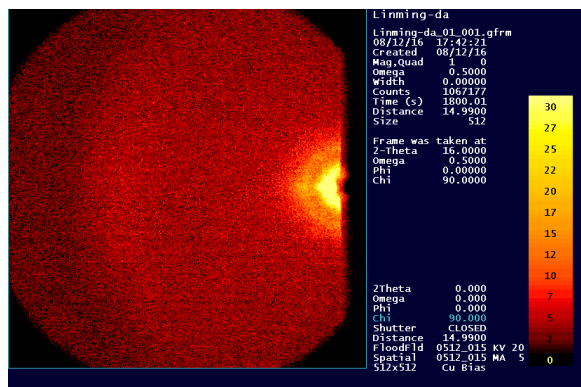
$$J = (8/9) \epsilon_r \epsilon_0 \mu (V^2/L^3) \quad (1)$$

where  $\epsilon_0$  is the permittivity of free space,  $\epsilon_r$  is the relative permittivity of the material,  $\mu$  is the electron mobility,  $V$  is the voltage drop across the device and  $L$  is the thickness of the film. For most polymers,  $\epsilon_r$  is around 3.

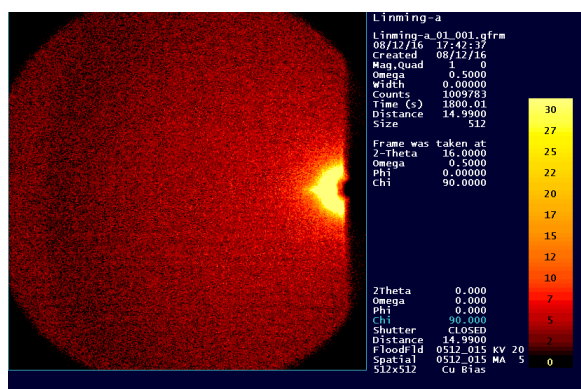
**Figure S1.** TGA plot of DMTPA-PDI<sub>3</sub> at a heating rate of 20 °C min<sup>-1</sup> under N<sub>2</sub> atmosphere.



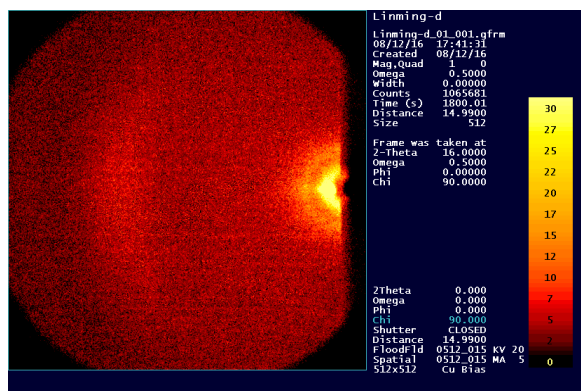
**Figure S2.** X-ray diffraction pattern of active layer PTB7-Th:DMTPA-PDI<sub>3</sub> (1.5:1 weight ratio, 3% CN).



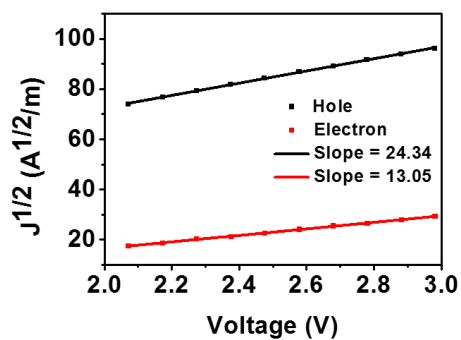
**Figure S3.** X-ray diffraction pattern of acceptor DMTPA-PDI<sub>3</sub>.



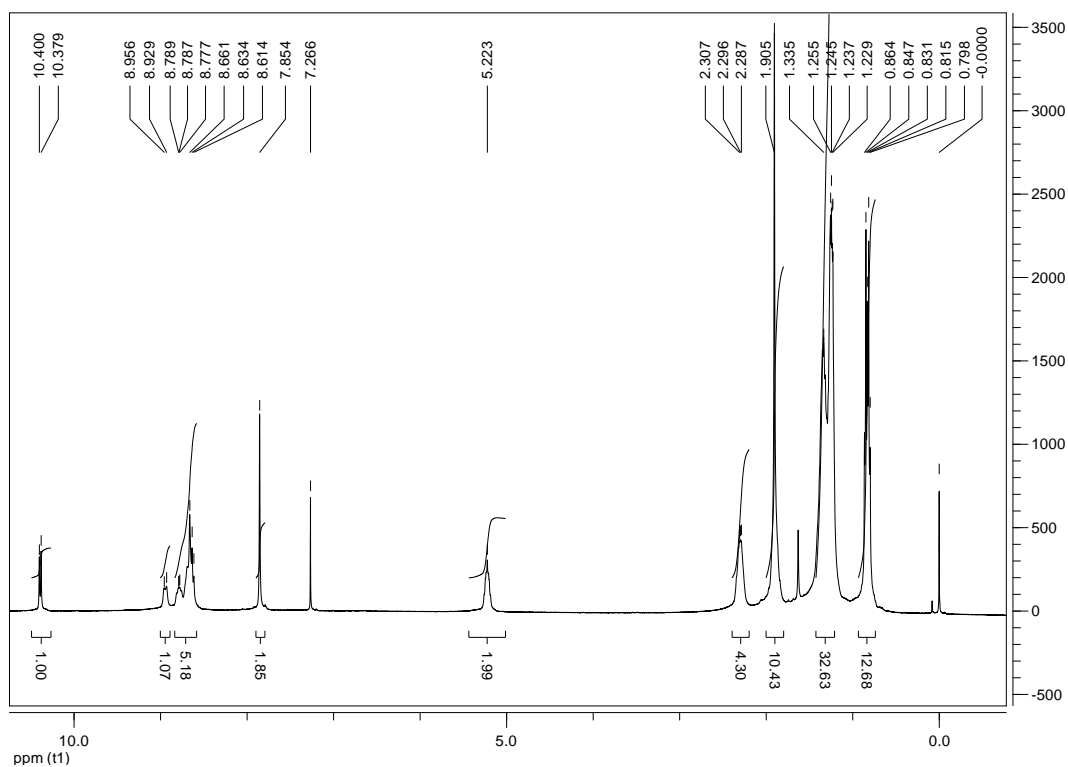
**Figure S4.** X-ray diffraction pattern of donor PTB7-Th.



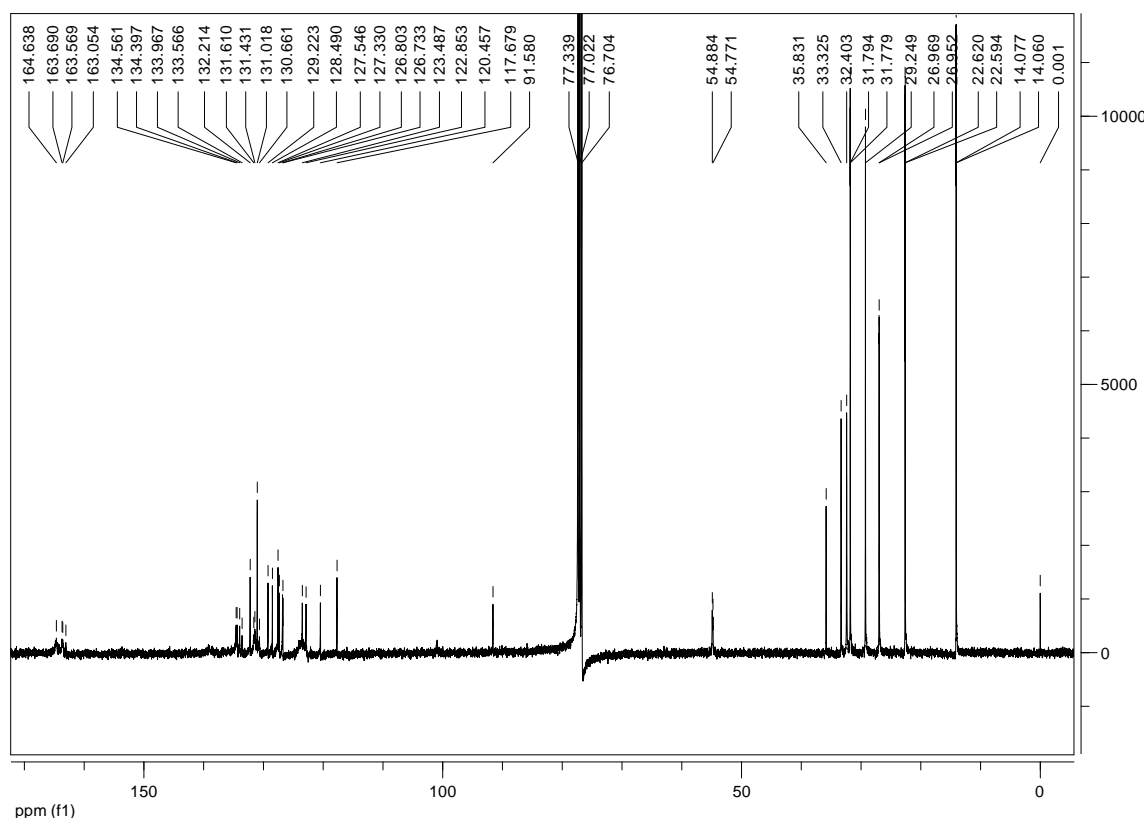
**Figure S5.**  $J_{1/2}$ - $V$  characteristics of the hole and electron-only devices



**Figure S6.** <sup>1</sup>H NMR of compound DMTPA-PDI<sub>3</sub>

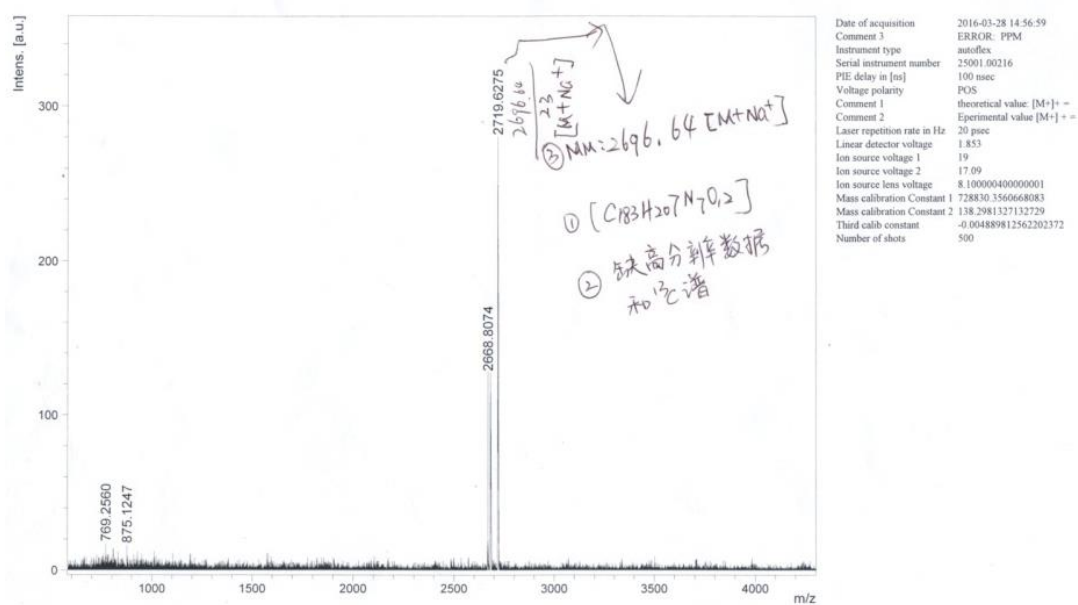


**Figure S7.**  $^{13}\text{C}$  NMR of compound **DMTPA-PDI<sub>3</sub>**



**Figure S8.** HR-MS (MALDI-TOF) mass spectrum of **DMTPA-PDI<sub>3</sub>**

**HONG KONG BAPTIST UNIVERSITY, DEPARTMENT OF CHEMISTRY (MALDI-TOF)**



Date of acquisition: 2016-03-28 14:56:59  
 Comment 3: ERROR: PPM  
 Instrument type: autoflex  
 Serial instrument number: 25001.00216  
 PIE delay in [ns]: 100  
 Voltage polarity: POS  
 Comment 1: theoretical value:  $[\text{M}]^+ -$   
 Comment 2: Experimental value:  $[\text{M}]^+ +$   
 Laser repetition rate in Hz: 20  
 Laser detector voltage: 1.853  
 Ion source voltage 1: 19  
 Ion source voltage 2: 17.09  
 Ion source lens voltage: 8.100000400000001  
 Mass calibration Constant 1: 728830.3560668083  
 Mass calibration Constant 2: 138.2981327132729  
 Third calib constant: -0.004889812562202372  
 Number of shots: 500

## References

- [1] Q. Yan, D. Zhao, *Org. Lett.* **2009**, *11*, 3426.
- [2] Z. Fang, V. Chellappan, R. D. Webster, L. Ke, T. Zhang, B. Liu, Y-H. Lai, *J. Mater. Chem.* **2012**, *22*, 15397.
- [3] M. J. Frisch, G. W. Trucks, H. B. Schlegel, G. E. Scuseria, M. A. Robb, J. R. Cheeseman, G. Scalmani, V. Barone, B. Mennucci, G. A. Petersson, H. Nakatsuji, M. L. Caricato, X.; , H. P. Hratchian, A. F. Izmaylov, J. Bloino, G. Zheng, J. L. Sonnenberg, M. Hada, M. Ehara, K. Toyota, R. Fukuda, J. Hasegawa, M. Ishida, T. Nakajima, Y. Honda, O. Kitao, H. Nakai, T. Vreven, J. Montgomery, J. A.; , J. E. Peralta, F. Ogliaro, M. Bearpark, J. J. Heyd, E. Brothers, K. N. Kudin, V. N. Staroverov, R. Kobayashi, J. Normand, K. Raghavachari, A. Rendell, J. C. Burant, S. S. Iyengar, J. Tomasi, M. Cossi, N. Rega, N. J. Millam, M. Klene, J. E. Knox, J. B. Cross, V. Bakken, C. Adamo, J. Jaramillo, R. Gomperts, R. E. Stratmann, O. Yazyev, A. J. Austin, R. Cammi, C. Pomelli, J. W. Ochterski, R. L. Martin, K. Morokuma, V. G. Zakrzewski, G. A. Voth, P. Salvador, J. J. Dannenberg, S. Dapprich, A. D. Daniels, Ö. Farkas, J. B. Foresman, J. V. Ortiz, J. Cioslowski, D. J. Fox, *Gaussian, Inc.*, Wallingford CT, **2009**.